# BGB420 Active Biased Transistor



Wireless Silicon Discretes



Never stop thinking.

Edition 2001-08-10

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BGB420 Data she Revision	eet ı History:	2001-08-10		
Previous	Version:	2000-11-28		
Page	Subjects (	Subjects (major changes since last revision)		
7	S-Parame	S-Parameter table added		
8	Figure "Ou	Figure "Output Compression Point" added		
9	SPICE Model added			

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#### BGB420 Active Biased Transistor

#### **BGB420**

#### Features

- For high gain low noise amplifiers
- Ideal for wideband applications, cellular telephones, cordless telephones, SAT-TV and high frequency oscillators
- G<sub>ma</sub>=17.5dB at 1.8GHz
- Small SOT343 package
- · Current easy adjustable by an external resistor
- Open collector output
- Typical supply voltage: 1.4-3.3V
- SIEGET<sup>®</sup>-25 technology





#### Description

 $\begin{array}{l} \text{SIEGET}^{\circledast}\text{-}25 \text{ NPN Transistor with integrated} \\ \text{biasing for high gain low noise figure} \\ \text{applications. } I_{C} \text{ can be controlled using } I_{\text{Bias}} \\ \text{according to } I_{C}\text{=}10^{*}I_{\text{Bias}} \\ \end{array}$ 

ESD: Electrostatic discharge sensitive device, observe handling precaution!

Туре	Package	Marking	Chip
BGB420	SOT343	MBs	T0514



#### **Maximum Ratings**

Parameter	Symbol	Value	Unit
Maximum collector-emitter voltage	V <sub>CE</sub>	3.5	V
Maximum collector current	Ι <sub>C</sub>	30	mA
Maximum bias current	I <sub>Bias</sub>	3	mA
Maximum emitter-base voltage	V <sub>EB</sub>	1.5	V
Maximum base current	I <sub>B</sub>	0.7	mA
Total power dissipation, $T_S < 107^{\circ}C^{1}$	P <sub>tot</sub>	120	mW
Junction temperature	Tj	150	°C
Operating temperature range	T <sub>OP</sub>	-40+85	°C
Storage temperature range	T <sub>STG</sub>	-65 +150	°C
Thermal resistance: junction-soldering point	R <sub>th JS</sub>	<270	K/W

Notes:

For detailed symbol description refer to figure 1.

 $^{1)}\,T_{\rm S}$  is measured on the emitter lead at the soldering point to the PCB



Fig. 1: Symbol definition





Fig. 2: Test Circuit for Electrical Characteristics and S-Parameter

**Electrical Characteristics** at  $T_A$ =25°C (measured in test circuit specified in fig. 2, min./max. values verified by random sampling)

Parameter	Symbol	min.	typ.	max.	Unit	
Maximum available power ga $V_D$ =2V, I <sub>c</sub> =20mA, f=1.8GHz	G <sub>MA</sub>	16.0	17.5		dB	
Insertion power gain $V_D=2V$ , $I_c=20mA$	f=0.9GHz f=1.8GHz	S <sub>21</sub>   <sup>2</sup>		22 16		dB
Insertion loss $V_D=2V$ , $I_c=0mA$	f=0.9GHz f=1.8GHz	IL		21 15		dB
Noise figure ( $Z_S$ =50 $\Omega$ ) V <sub>D</sub> =2V, I <sub>c</sub> =5mA	f=0.9GHz f=1.8GHz	$F_{50\Omega}$		1.3 1.5	1.8 2.0	dB
Output power at 1dB gain con $V_D$ =2V, I <sub>c</sub> =20mA, f=1.8GHz	npression Z <sub>L</sub> =Z <sub>LOPT</sub> Z <sub>L</sub> =50Ω	P <sub>-1dB</sub>	7	12 10		dBm
Output third order intercept pr V <sub>D</sub> =2V, I <sub>c</sub> =20mA, f=1.8GHz	oint $Z_{L/S}=Z_{L/SOPT}$ $Z_{L/S}=50\Omega$	OIP <sub>3</sub>	17	22 20		dBm
Collector-base capacitance V <sub>CB</sub> =2V, f=1MHz		C <sub>CB</sub>		0.16		pF
Current Ratio $I_C/I_{Bias}$ $I_{Bias}$ =0.5mA, $V_D$ =3V		CR	7	10	13	



Frequency	S11	S11	S21	S21	S12	S12	S22	S22
[GHz]	Mag	Ang	Mag	Ang	Mag	Ang	Mag	Ang
0.1	0.4412	-24.8	35.7070	160.6	0.0078	83.5	0.9225	-14.1
0.2	0.4064	-47.4	31.7670	143.9	0.0157	77.5	0.8321	-26.2
0.4	0.3261	-81.6	23.1980	120.9	0.0261	70.9	0.6380	-41.4
0.6	0.2854	-105.8	17.2590	106.9	0.0351	69.4	0.5012	-49.6
0.8	0.2615	-124.2	13.5050	97.5	0.0444	68.9	0.4100	-54.2
1.0	0.2525	-136.4	10.9810	90.6	0.0537	68.2	0.3435	-57.4
1.2	0.2505	-148.9	9.1940	84.8	0.0628	67.3	0.2946	-60.2
1.4	0.2476	-158.2	7.8930	80.1	0.0720	65.9	0.2571	-62.6
1.6	0.2533	-167.1	6.9070	75.6	0.0819	64.6	0.2228	-64.2
1.8	0.2579	-173.3	6.1460	71.7	0.0915	62.9	0.1966	-66.0
2.0	0.2584	-178.7	5.5300	68.2	0.1009	61.4	0.1751	-66.3
3.0	0.2874	157.6	3.6990	51.6	0.1495	51.7	0.0802	-70.1
4.0	0.3505	139.0	2.7770	36.1	0.1970	40.4	0.0366	-178.8
5.0	0.4061	125.9	2.1930	21.5	0.2392	29.4	0.0913	126.7
6.0	0.4450	117.1	1.8050	8.6	0.2864	18.9	0.1340	99.8

### **S-Parameter** $V_D$ =2V, $I_C$ =20mA (see Electrical Characteristics for conditions)

## **Device Current** I $_{D} = f(V_{D}, R_{Bias})$





## Power Gain $|S_{21}|^2$ , Gma, Gms=f(f) $V_D = 3V$ , $I_C = 20mA$







**Power Gain** Gma,  $Gms=f(I_C)$  $V_D = 3V$ 



**Output Compression Point** 





#### SPICE Model

#### BGB420-Chip



Q1	T502
Q2	T502 (area factor: 0.1)
R1	2.7kΩ
R2	27kΩ

#### Transistor Chip Data T502 (Berkley-SPICE 2G.6 Syntax)

.MODEL T502 NPN(

+ IS = 2.0045e-16	BF = 72.534	NF = 1.2432	VAF = 28.383
+ IKF = 0.48731	ISE = 1.9049e-14	NE = 2.0518	BR = 7.8287
+ NR = 1.3325	VAR = 19.705	IKR = 0.69141	ISC = 1.9237e-17
+ NC = 1.1724	RB = 8.5757	IRB = 0.00072983	RBM = 3.4849
+ RE = 0.31111	RC = 0.10105	CJE = 1.8063e-15	VJE = 0.8051
+ MJE = 0.46576	TF = 6.7661e-12	XTF = 0.42199	VTF = 0.23794
+ ITF = 0.001	PTF = 0	CJC = 2.3453e-13	VJC = 0.81969
+ MJC = 0.30232	XCJC = 0.3	TR = 2.3249e-09	CJS= 0
+ VJS = 0.75	MJS = 0	XTB = 0	EG = 1.11
+ XTI = 3	FC = 0.73234)		

#### Package Equivalent Circuit



L <sub>BI</sub>	0.36	nH
L <sub>B0</sub>	0.4	nH
L <sub>EI</sub>	0.3	nH
L <sub>EO</sub>	0.15	nH
L <sub>CI</sub>	0.36	nH
L <sub>CO</sub>	0.4	nH
L <sub>1</sub>	0.6	nH
L <sub>2</sub>	0.4	nH
C <sub>BE</sub>	95	fF
C <sub>CB</sub>	6	fF
C <sub>CE</sub>	132	fF
C <sub>1</sub>	28	fF
C <sub>2</sub>	88	fF
C <sub>3</sub>	8	fF

Valid up to 3GHz



## **Typical Application**



Fig. 3: Typical application circuit. This proposal demonstrates how to use the BGB420 as a Self-Biased Transistor. As for a discrete Transistor matching circuits have to be applied. A good starting point for various applications are the Application Notes provided for the BFP420.

#### **Package Outline**



0.1 max A .25±0.1 0.15<sup>+0.1</sup><sub>-0.05</sub> 0.20 🕅 A

GPS05605